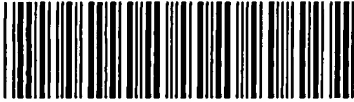


Search Notes

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Examiner

Christopher P. Schwartz

Applicant(s)/Patent under
Reexamination

WALKER, FRANK H

Art Unit

3683

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR